

INA183 2.7V 至 26V、高精度电流检测放大器

1 特性

- 宽共模范围：2.7V 至 26V
- 失调电压： $\pm 170\mu\text{V}$ (最大值)
(支持 10mV 满量程分流压降)
- 精度：
 - 增益误差 $\pm 0.4\%$ (最高过热温度)：
 - $0.5\mu\text{V}/^\circ\text{C}$ 偏移漂移 (最大值)
 - $10\text{ppm}/^\circ\text{C}$ 增益漂移 (最大值)
- 增益选择：
 - INA183A1：50V/V
 - INA183A2：100V/V
 - INA183A3：200V/V
- 静态电流：130 μA (最大值)
- 封装：5 引脚 SOT-23

2 应用

- 服务器
- 电源
- 电池管理
- 电信设备

3 说明

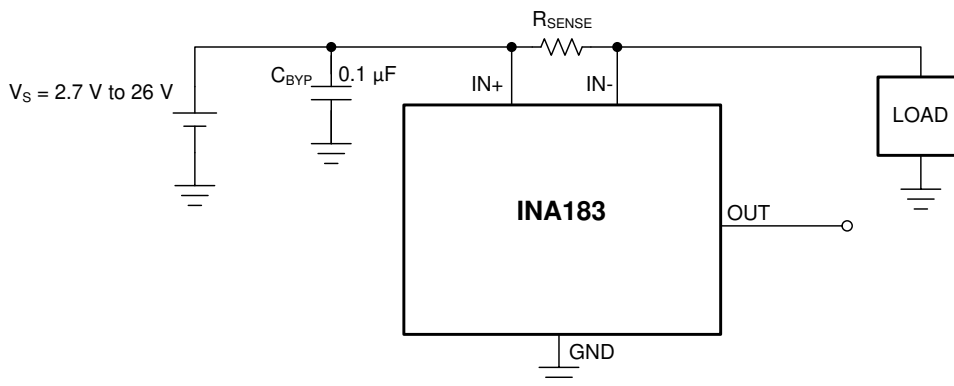
INA183 是一款高精度电压输出、电流分流监控器 (也称为电流检测放大器)，常用于过流保护、针对系统优化的精密电流测量或闭环反馈电路。该器件可在独立于电源电压的 2.7V 至 26V 共模电压下感应分流电阻器上的电压降。50 V/V、100V/V 和 200 V/V。零漂移架构的低偏移使得该器件能够在分流器上的最大压降低至 10mV (满量程) 的情况下进行电流感应。

该器件通过从 IN+ 引脚获取功率而运行，消耗的最大电源电流为 130 μA 。所有版本的额定工作温度范围为 -40°C 至 125°C ，并且采用 5 引脚的 SOT-23 封装。

器件信息⁽¹⁾

器件型号	封装	封装尺寸 (标称值)
INA183	SOT-23 (5)	2.90mm × 1.60mm

(1) 如需了解所有可用封装，请参阅数据表末尾的可订购产品附录。



典型应用



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4 Revision History

注：以前版本的页码可能与当前版本的页码不同

DATE	VERSION	NOTES
February 2021	*	Initial Release.

5 Device Comparison

表 5-1. Device Comparison

PRODUCT	GAIN
INA183A1	50
INA183A2	100
INA183A3	200

6 Pin Configuration and Functions

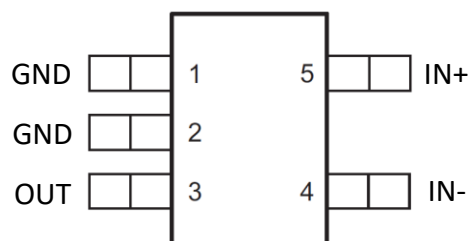


图 6-1. DBV Package 5-Pin SOT-23 Top View

表 6-1. Pin Functions

PIN		I/O	DESCRIPTION
NAME	SOT-23		
GND	1, 2	Analog	Device ground. Both pins must be connected to ground.
IN -	4	Analog input	Connect to load side of shunt resistor.
IN+	5	Analog input	Connect to supply side of shunt resistor.
OUT	3	Analog output	Output voltage.

7 Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
Analog inputs, V_{IN+} , V_{IN-} ⁽¹⁾	Differential ($V_{IN+} - V_{IN-}$)	GND – 0.3	26	V
	Common-mode ⁽²⁾	GND – 0.3	26	V
Output ⁽²⁾		GND – 0.3	(V_{IN+}) + 0.3	V
Operating temperature		– 55	150	°C
Junction temperature			150	°C
Storage temperature, T_{stg}		– 65	150	°C

(1) V_{IN+} and V_{IN-} are the voltages at the $IN+$ and $IN-$ terminals, respectively.

(2) Input voltage at any terminal may exceed the voltage shown if the current at that terminal is limited to 5 mA.

7.2 ESD Ratings

			MIN	MAX	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾		±3500	V
		Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾		±1000	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V_S	Supply voltage range, voltage at $IN+$ pin	2.7	12	26	V
T_A	Operating free-air temperature	– 40		125	°C

7.4 Thermal Information

THERMAL METRIC ⁽¹⁾		INA183	UNIT
		DBV (SOT-23)	
		5 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	164.2	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	60.1	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	36.6	°C/W
ψ_{JT}	Junction-to-top characterization parameter	10.3	°C/W
ψ_{JB}	Junction-to-board characterization parameter	36.3	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

7.5 Electrical Characteristics

at $T_A = 25\text{ }^{\circ}\text{C}$, $V_{\text{SENSE}} = V_{\text{IN}+} - V_{\text{IN}-}$, and $V_{\text{IN}+} = 12\text{ V}$, unless otherwise noted.

PARAMETER			CONDITIONS	MIN	TYP	MAX	UNIT
INPUT							
V _{CM}	Common-mode input range		T _A = - 40 °C to +125 °C	2.7		26	V
CMRR	Common-mode rejection ratio		V _{IN+} = 2.7 V to 26 V, V _{SENSE} = 10 mV, T _A = - 40 °C to +125 °C	100	120		dB
V _{OS}	Offset voltage, RTI ⁽¹⁾		V _{CM} = 12 V		±25	±170	μ V
dV _{OS} /dT	RTI vs temperature		T _A = - 40 °C to +125 °C		0.1	0.5	μ V/°C
I _{IB}	Input bias current (IB-)		V _{SENSE} = 0 mV		30	40	μ A
OUTPUT							
G	Gain	A1 devices			50		V/V
		A2 devices			100		V/V
		A3 devices			200		V/V
E _G	Gain error		V _{OUT} = 0.5 V to V _{IN+} - 0.5 V, T _A = - 40 °C to +125 °C		±0.1%	±0.4%	
	Gain error vs temperature		T _A = - 40 °C to +125 °C		3	10	ppm/°C
	Nonlinearity error		V _{OUT} = 0.5 V to V _{IN+} - 0.5 V		±0.01%		
	Maximum capacitive load		No sustained oscillation		1		nF
VOLTAGE OUTPUT							
V _{SP}	Swing to IN+		R _L = 10 kΩ to GND, T _A = - 40 °C to +125 °C		(V _{IN+}) - 0.05	(V _{IN+}) - 0.2	V
V _{SN}	Swing to GND		R _L = 10 kΩ to GND, V _{IN+} - V _{IN-} = -10 mV, T _A = - 40 °C to +125 °C		(V _{GND}) + 0.005	(V _{GND}) + 0.05	V
FREQUENCY RESPONSE							
BW	Bandwidth	A1 devices	C _{LOAD} = 10 pF		80		kHz
		A2 devices	C _{LOAD} = 10 pF		30		kHz
		A3 devices	C _{LOAD} = 10 pF		14		kHz
SR	Slew rate				0.4		V/ μ s
NOISE, RTI ⁽¹⁾							
	Voltage noise density				25		nV/ √ Hz
POWER SUPPLY							
I _Q	Quiescent current, (IN+)		V _{SENSE} = 0 mV		83	130	μ A
	I _Q over temperature		T _A = - 40 °C to +125 °C			140	μ A

(1) RTI = referred-to-input.

7.6 Typical Characteristics

$T_A = 25\text{ }^{\circ}\text{C}$, $V_S = V_{IN+} = 12\text{ V}$ (unless otherwise noted)

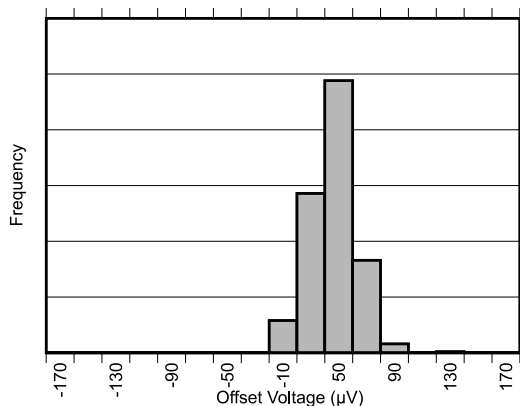


图 7-1. Input Offset Voltage Production Distribution

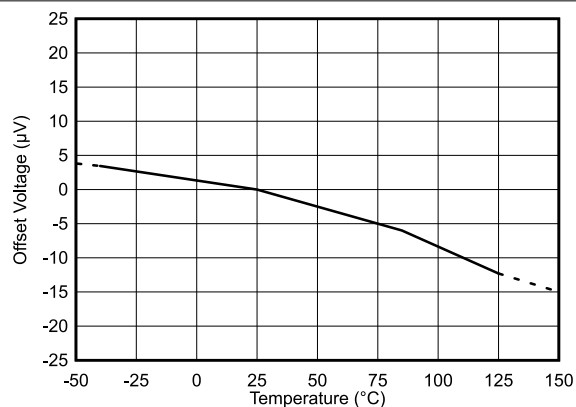


图 7-2. Offset Voltage vs. Temperature

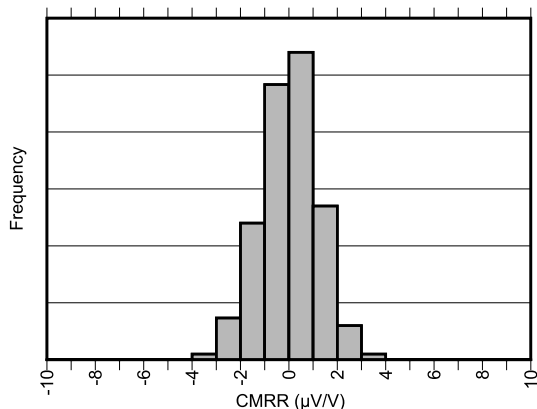


图 7-3. Common-Mode Rejection Production Distribution (A1 Devices)

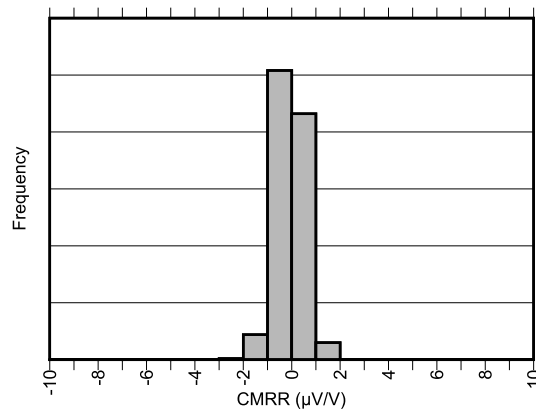


图 7-4. Common-Mode Rejection Production Distribution (A2 Devices)

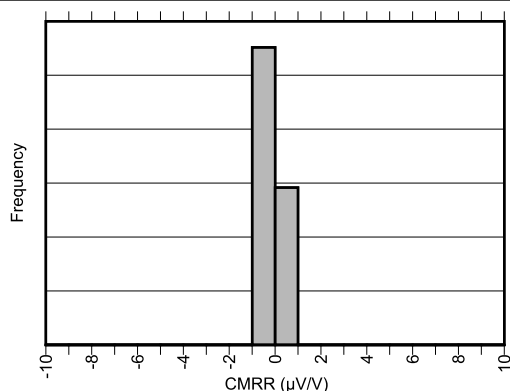


图 7-5. Common-Mode Rejection Production Distribution (A3 Devices)

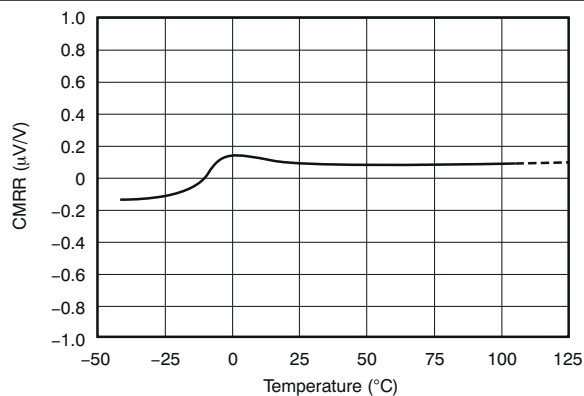


图 7-6. Common-Mode Rejection Ratio vs. Temperature

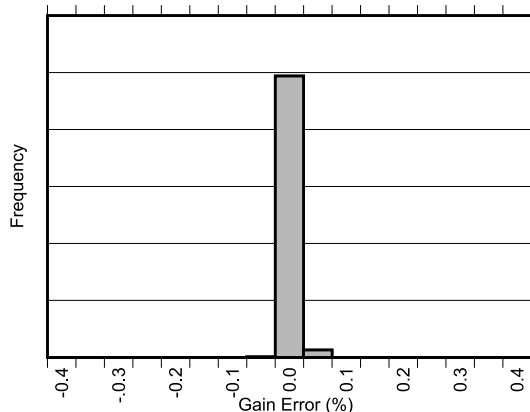


图 7-7. Gain Error Production Distribution (A1 Devices)

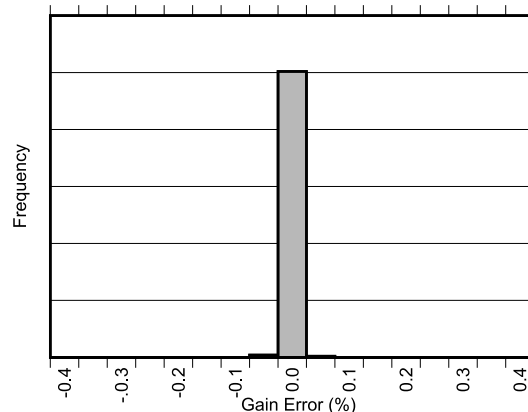


图 7-8. Gain Error Production Distribution (A2 Devices)

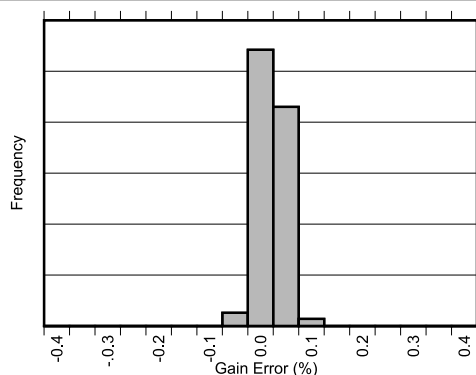


图 7-9. Gain Error Production Distribution (A3 Devices)

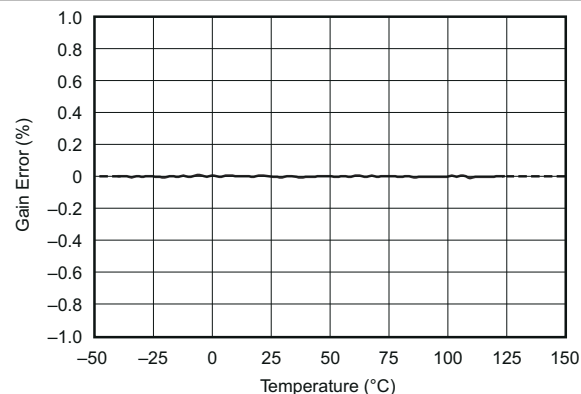


图 7-10. Gain Error vs. Temperature

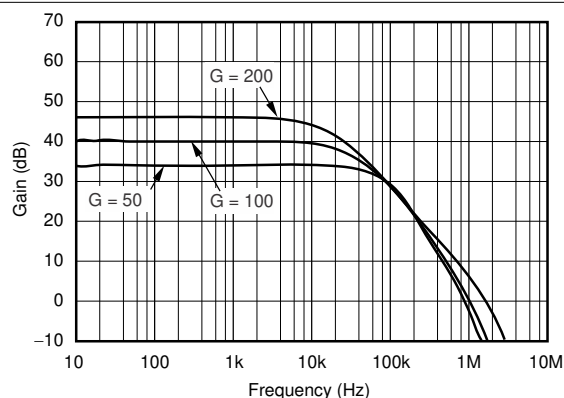


图 7-11. Gain vs. Frequency

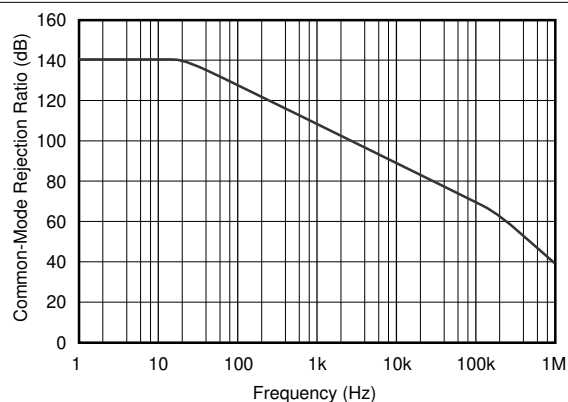


图 7-12. Common-Mode Rejection Ratio vs. Frequency

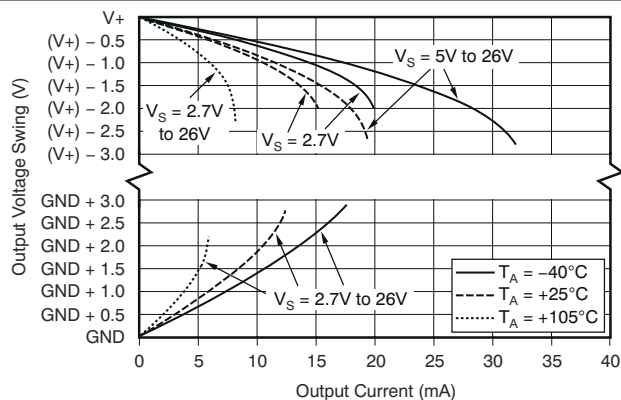


图 7-13. Output Voltage Swing vs. Output Current

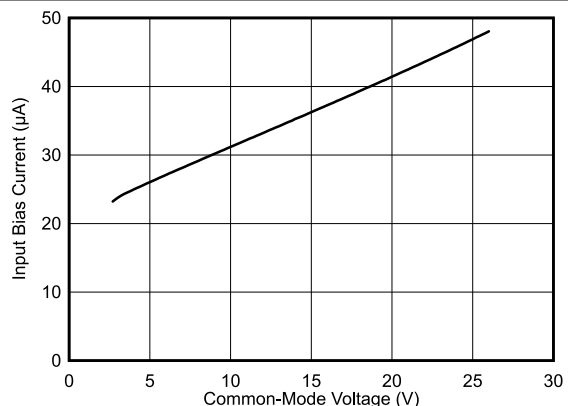


图 7-14. Input Bias Current vs. Common-Mode Voltage

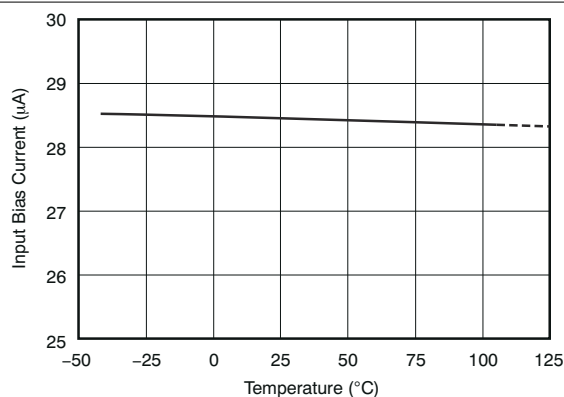


图 7-15. Input Bias Current vs. Temperature

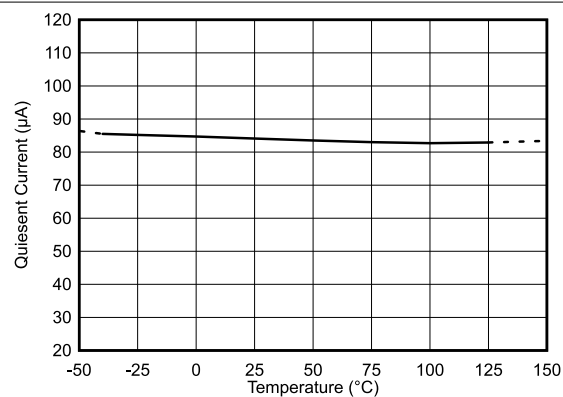


图 7-16. Quiescent Current vs. Temperature

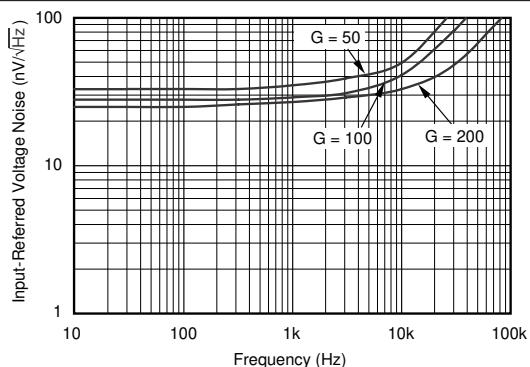


图 7-17. Input-Referred Voltage Noise vs. Frequency

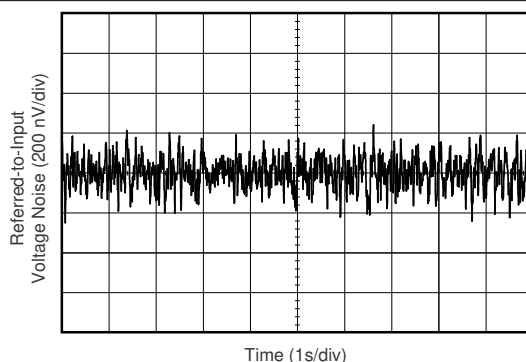


图 7-18. 0.1-Hz to 10-Hz Voltage Noise (Referred-to-Input)

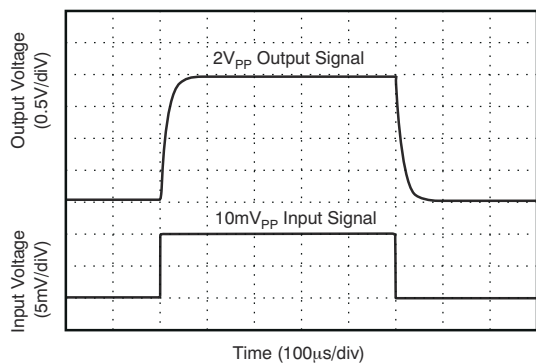


图 7-19. Step Response (10-mV_{PP} Input Step)

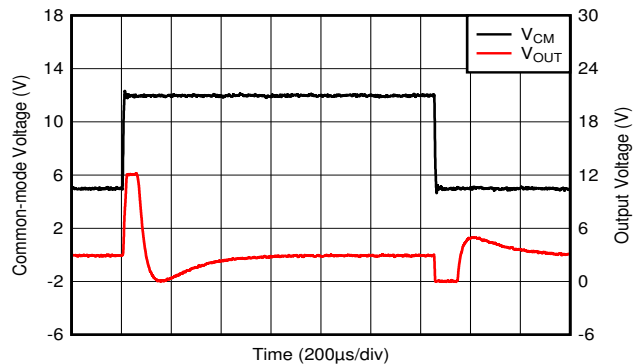


图 7-20. Common-Mode Voltage Transient Response

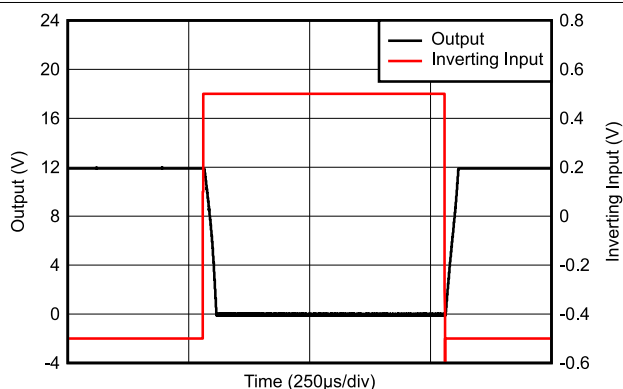
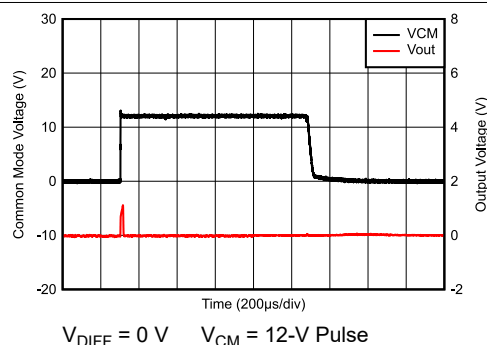


图 7-21. Inverting Differential Input Overload



$V_{DIFF} = 0\text{ V}$ $V_{CM} = 12\text{-V Pulse}$

图 7-22. Start-Up Response

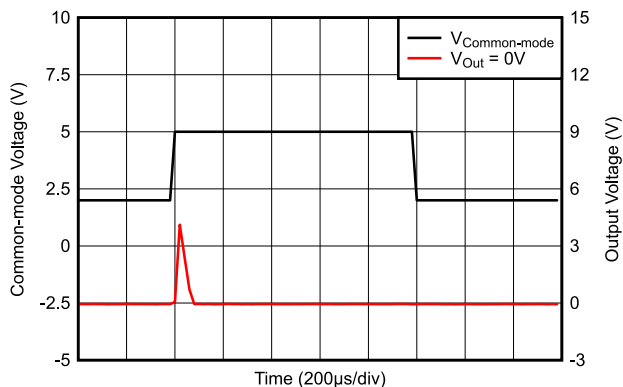


图 7-23. Brownout Recovery

8 Detailed Description

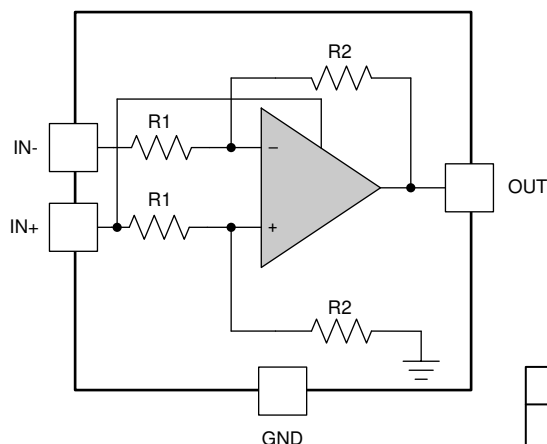
8.1 Overview

The INA183 is a 26-V common-mode, zero-drift topology, current-sensing amplifier meant for high-side, current-sensing applications. The device is a specially-designed, current-sensing amplifier that can accurately measure voltages developed across a current-sensing resistor. The device is capable of measuring current on input voltage rails as high as 26 V and as low as 2.7 V.

The zero-drift topology enables high-precision measurements with maximum input offset voltages as low as 170 μV with a maximum temperature contribution of 0.5 $\mu\text{V}/^\circ\text{C}$ over the full temperature range of -40°C to $+125^\circ\text{C}$.

8.2 Functional Block Diagram

The simplified functional diagram below shows the device power is provided by the voltage on the IN+ pin. This diagram also shows the nominal values for the internal gain set resistors. The nominal value of these resistors can vary by 20% or more; however, the matching between these resistors is tightly controlled. The matching of these internal resistors results in a precise fixed gain that varies very little over temperature.



DEVICE	GAIN	R1	R2
INA183A1	50	20 k Ω	1 M Ω
INA183A2	100	10 k Ω	1 M Ω
INA183A3	200	5 k Ω	1 M Ω

8.3 Feature Description

8.3.1 Single-Supply Operation from IN+

The INA183 does not have a dedicated power-supply. Instead, an internal connection to the IN+ pin serves as the power supply for this device. This allows the device to be used in applications where lower voltage or sub-regulated supply rails are not present. The operational voltage range on this pin is 2.7 V to 26 V and is designed for power-supply applications. The maximum current drawn from the IN+ pin is 130 μA , when the current sense voltage is zero.

8.3.2 Low Gain Error and Offset Voltage

The maximum gain error of the INA183 is 0.4% and is specified over the full operational temperature range. The low gain error allows for accurate measurements as the sense voltage increases, and is designed for applications that need to detect overcurrent conditions accurately. The offset voltage of the INA183 is specified to be $\pm 170 \mu\text{V}$ for all gain options. The low offset voltage allows for increased accuracy when the sense voltage is small or allows for reduction in the size of the current sense resistor with less impact on the total measurement accuracy. Smaller value resistors reduce the power loss in the application which allows the use of lower wattage resistors that are generally lower cost.

8.3.3 Low Drift Architecture

The INA183 features low drift for both the gain error and offset voltage specifications. The low gain error drift of 10 PPM/ $^\circ\text{C}$ results from the well matched internal resistor network that sets the device gain. The low offset drift

is due to the internal chopping architecture of the amplifier. Input chopping reduces both the offset and offset drift since any change in offset is canceled with each chopping cycle. The maximum input offset drift of the INA183 is $0.5 \mu\text{V}/^\circ\text{C}$. The low drift of the gain error and offset voltage provides accurate current measurement over the operational temperature range of -40°C to 125°C that exceeds the performance of most discrete current sensing implementations.

8.4 Device Functional Modes

8.4.1 Normal Operation

The INA183 is in normal operation when the following conditions are met:

- The voltage at the IN+ pin is between 2.7 V and 26 V.
- The maximum differential input signal times the gain is less than $V_{\text{IN}+}$ minus the output voltage swing to $V_{\text{IN}+}$.
- The minimum differential input signal times the gain is greater than the swing to GND.

During normal operation, this device produces an output voltage that is the *amplified* representation of the difference voltage from IN+ to IN-.

8.4.2 Unidirectional, High-Side Operation

The INA183 measures the differential voltage developed by current flowing through a resistor that is commonly referred to as a current shunt resistor or current-sensing resistor. The INA183 operates in high-side, unidirectional mode only, meaning it only senses current sourced from a power supply to a system load as shown in [图 8-1](#).

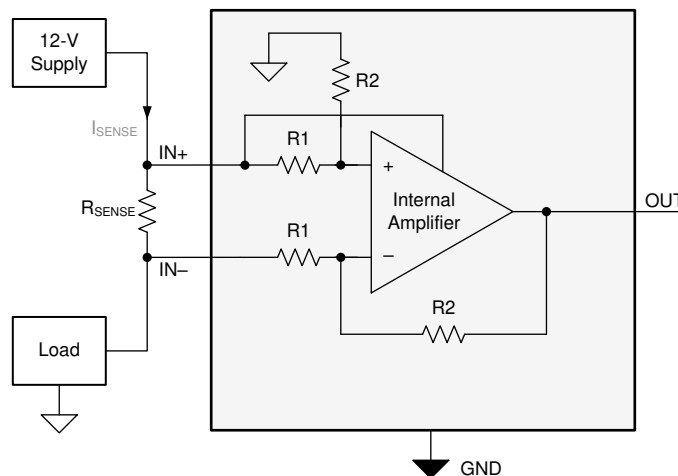


图 8-1. High-Side Unidirectional Application

8.4.3 Input Differential Overload

If the differential input voltage ($V_{\text{IN}+} - V_{\text{IN}-}$) times gain exceeds the voltage swing specification, the INA183 drives the output as close as possible to the IN+ pin or ground, and does not provide accurate measurement of the differential input voltage. If this input overload occurs during normal circuit operation, then reduce the value of the shunt resistor or use a lower-gain version with the chosen sense resistor to avoid this mode of operation. If a differential overload occurs in a fault event, then the output of the INA183 returns to the expected value approximately 30 μs after removal of the fault condition. When the input differential voltage is overloaded the bias currents will increase by a significant amount. The increase in bias currents will occur even with the device is powered down. Input differential overloads less than the absolute maximum voltage rating do not damage the device or result in an output inversion.

9 Application and Implementation

备注

以下应用部分中的信息不属于 TI 器件规格的范围，TI 不担保其准确性和完整性。TI 的客户应负责确定器件是否适用于其应用。客户应验证并测试其设计，以确保系统功能。

9.1 Application Information

The INA183 measures the voltage developed across a current-sensing resistor when current passes through it. The ability to drive the reference pin to adjust the functionality of the output signal offers multiple configurations, as discussed throughout this section.

9.1.1 R_{SENSE} and Device Gain Selection

Choosing the largest possible shunt resistor will maximize the accuracy of any current-sense amplifier. A large sense resistor maximizes the differential input signal for a given amount of current flow and reduces the error contribution of the offset voltage. However, there are practical limits as to how large the current-sense resistor can be in a given application because of the resistor size and maximum allowable power dissipation. 方程式 1 gives the maximum value for the current-sense resistor for a given power dissipation budget:

$$R_{\text{SENSE}} < \frac{PD_{\text{MAX}}}{I_{\text{MAX}}^2} \quad (1)$$

where:

- PD_{MAX} is the maximum allowable power dissipation in R_{SENSE} .
- I_{MAX} is the maximum current expected to flow through R_{SENSE} .

An additional limitation on the size of the current-sense resistor and device gain is due to the power-supply voltage at the IN+ pin, and device swing-to-rail limitations. To ensure that the current-sense signal is properly passed to the output, both positive and negative output swing limitations must be examined. 方程式 2 provides the maximum values of R_{SENSE} and GAIN to keep the device from exceeding the positive swing limitation.

$$I_{\text{MAX}} \times R_{\text{SENSE}} \times \text{GAIN} < V_{\text{SP}} \quad (2)$$

where:

- I_{MAX} is the maximum current that will flow through R_{SENSE} .
- GAIN is the gain of the current-sense amplifier.
- V_{SP} is the positive output swing as specified in the data sheet.

Positive output swing limitations should be considered when selecting the value of R_{SENSE} . There is always a trade-off between the value of the sense resistor and the gain of the device under consideration. If the sense resistor selected for the maximum power dissipation is too large, then it is possible to select a lower-gain device to avoid positive swing limitations.

The negative swing specification limits how small the sense resistor value can be for a given application. 方程式 3 provides the limit on the minimum value of the sense resistor.

$$I_{\text{MIN}} \times R_{\text{SENSE}} \times \text{GAIN} > V_{\text{SN}} \quad (3)$$

where:

- I_{MIN} is the minimum current that will flow through R_{SENSE} .
- GAIN is the gain of the current-sense amplifier.
- V_{SN} is the negative output swing of the device.

9.2 Typical Application

图 9-1 shows the basic connections for the INA183. The input pins, IN+ and IN−, must be connected as close as possible to the shunt resistor to minimize any resistance in series with the shunt resistor.

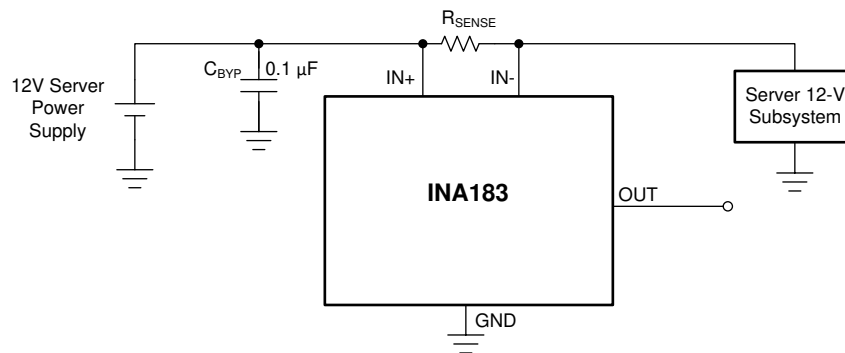


图 9-1. Typical Server Application

A power-supply bypass capacitor is required on the IN+ pin. Applications with noisy or high-impedance power supplies may require additional decoupling capacitors to reject power-supply noise. Connect bypass capacitors close to the device pins.

In server applications, the INA183 typically monitors the current on the 12-V bus that is distributed to various server sub-systems like memory, storage, or CPU power. The monitored current can be used by the server for fault detection or sub-system power optimization.

9.2.1 Design Requirements

表 9-1 lists the design setup for this application.

表 9-1. Design Parameters

DESIGN PARAMETERS	EXAMPLE VALUE
High-side supply voltage ($V_{\text{IN+}}$)	12 V
Maximum sense current (I_{MAX})	5 A
Gain option	50 V/V

9.2.2 Detailed Design Procedure

The maximum value of the current-sense resistor is calculated based on choice of gain, the value of the maximum current to be sensed (I_{MAX}), and the power-supply voltage ($V_{\text{IN+}}$). When operating at the maximum current, the output voltage must not exceed the positive output swing specification, V_{SP} . Under the given design parameters, 方程式 4 calculates the maximum value for R_{SENSE} as 47.2 mΩ.

$$R_{\text{SENSE}} < \frac{V_{\text{SP}}}{I_{\text{MAX}} \times \text{GAIN}} \quad (4)$$

For this design example, a value of $40.2\text{ m}\Omega$ is selected because, while the $40.2\text{ m}\Omega$ is less than the maximum value calculated, $40.2\text{ m}\Omega$ is still large enough to give an adequate signal at the current-sense amplifier output. To reduce resistor power losses or to operate over a reduced output range, smaller value resistors can be used as the expense of dynamic range and low current accuracy.

9.2.3 Application Curve

图 9-2 shows the output response of the device to a sinusoidal current.

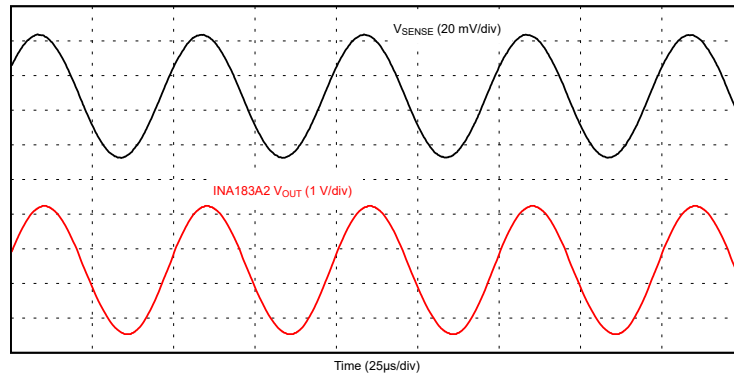


图 9-2. INA183 Output Response

10 Power Supply Recommendations

The device is powered from the IN+ pin with a voltage from 2.7 V to 26 V. The voltage at the output will also be limited by this voltage during overload or fault conditions. Also, the INA183 can withstand the full input signal range up to 26 V on the IN – pin, regardless of whether the device has power applied or not.

11 Layout

11.1 Layout Guidelines

- Connect the input pins to the sensing resistor using a kelvin or 4-wire connection. This connection technique ensures that only the current-sensing resistor impedance is detected between the input pins. Poor routing of the current-sensing resistor commonly results in additional resistance present between the input pins. Given the very low ohmic value of the current resistor, any additional high-current carrying impedance can cause significant measurement errors.
- Place the power-supply bypass capacitor as close as possible to the IN+ pin and ground pins. TI recommends using a bypass capacitor with a value of 0.1 μ F. Additional decoupling capacitance can be added to compensate for noisy or high-impedance power supplies.

11.2 Layout Example

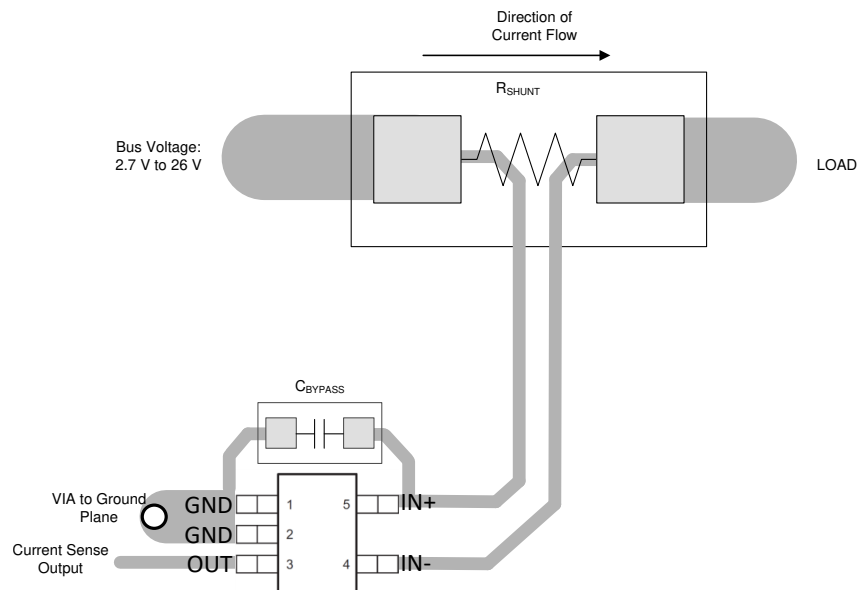


图 11-1. Recommended Layout

12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Related Documentation

For related documentation see the following:

- [INA183A1-A3EVM User's Guide](#)
- [TIDA-00302 Transient Robustness for Current Shunt Monitor](#)

12.2 接收文档更新通知

要接收文档更新通知，请导航至 [ti.com](https://www.ti.com) 上的器件产品文件夹。点击 [订阅更新](#) 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

12.3 支持资源

TI E2E™ 支持论坛 是工程师的重要参考资料，可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

链接的内容由各个贡献者“按原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的《[使用条款](#)》。

12.4 Trademarks

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12.5 静电放电警告



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ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

12.6 术语表

TI 术语表 本术语表列出并解释了术语、首字母缩略词和定义。

13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
INA183A1IDBVR	Active	Production	SOT-23 (DBV) 5	3000 LARGE T&R	Yes	SN	Level-2-260C-1 YEAR	-40 to 125	2BRQ
INA183A1IDBVR.B	Active	Production	SOT-23 (DBV) 5	3000 LARGE T&R	Yes	SN	Level-2-260C-1 YEAR	-40 to 125	2BRQ
INA183A2IDBVR	Active	Production	SOT-23 (DBV) 5	3000 LARGE T&R	Yes	SN	Level-2-260C-1 YEAR	-40 to 125	2BSQ
INA183A2IDBVR.B	Active	Production	SOT-23 (DBV) 5	3000 LARGE T&R	Yes	SN	Level-2-260C-1 YEAR	-40 to 125	2BSQ
INA183A2IDBVT	Obsolete	Production	SOT-23 (DBV) 5	-	-	Call TI	Call TI	-40 to 125	2BSQ
INA183A3IDBVR	Active	Production	SOT-23 (DBV) 5	3000 LARGE T&R	Yes	SN	Level-2-260C-1 YEAR	-40 to 125	2BTQ
INA183A3IDBVR.B	Active	Production	SOT-23 (DBV) 5	3000 LARGE T&R	Yes	SN	Level-2-260C-1 YEAR	-40 to 125	2BTQ
INA183A3IDBVT	Obsolete	Production	SOT-23 (DBV) 5	-	-	Call TI	Call TI	-40 to 125	2BTQ

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

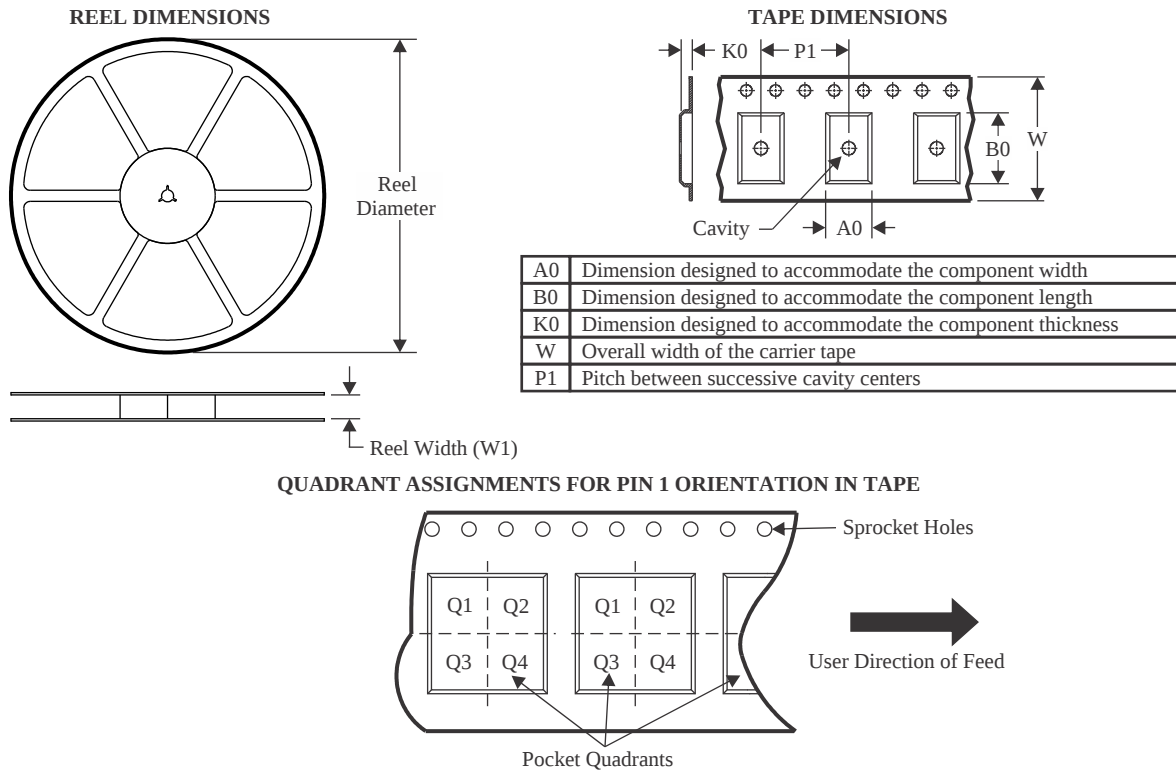
⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
INA183A1IDBVR	SOT-23	DBV	5	3000	178.0	9.0	3.3	3.2	1.4	4.0	8.0	Q3
INA183A2IDBVR	SOT-23	DBV	5	3000	178.0	9.0	3.3	3.2	1.4	4.0	8.0	Q3
INA183A3IDBVR	SOT-23	DBV	5	3000	178.0	9.0	3.3	3.2	1.4	4.0	8.0	Q3

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
INA183A1IDBVR	SOT-23	DBV	5	3000	190.0	190.0	30.0
INA183A2IDBVR	SOT-23	DBV	5	3000	190.0	190.0	30.0
INA183A3IDBVR	SOT-23	DBV	5	3000	190.0	190.0	30.0



SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Reference JEDEC MO-178.
4. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25 mm per side.
5. Support pin may differ or may not be present.

EXAMPLE BOARD LAYOUT

DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:15X



SOLDER MASK DETAILS

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NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:15X

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NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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